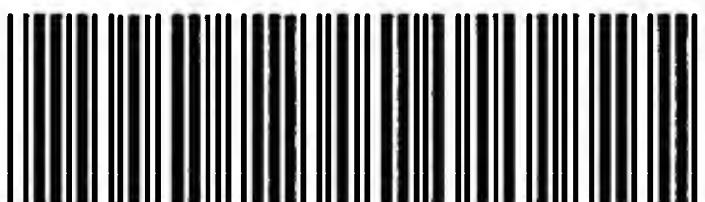


Search Notes



Application/Control No.

10/710,297

Examiner

Thinh H. Nguyen

**Applicant(s)/Patent under
Reexamination**

MATSUMOTO ET AL.

Art Unit

2861

SEARCHED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)